



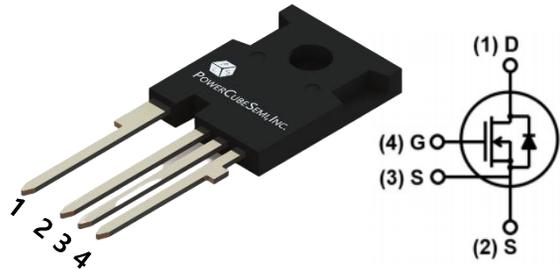
PCM030R120EP

1,200V 80A 30mΩ Silicon Carbide MOSFET

Features

- Low Switching losses
- Low Gate Charge
- High frequency operation
- Fast reverse recovery body diode
- Little temperature-dependent on-resistance variation

Package Outline



Applications

- Photovoltaic Inverter
- Electric Vehicle Charging Station
- Switching Power Supply
- Motor Drives
- Uninterruptible Power Supply, UPS

- (1) D (Drain)
- (2) S (Source)
- (3) S (Driver Source)
- (4) G (Gate)



Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	1200	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$) - Continuous ($T_C = 100^\circ\text{C}$)	80	A
		60	A
I_{DM}	Drain Current - Pulsed	170	A
$V_{GSS\ Max}$	Gate-Source Voltage	-10 / +22	V
V_{GSS}	Gate-Source Voltage (Recommended operational)	-3 / +18	V
P_D	Power Dissipation - Continuous ($T_C = 25^\circ\text{C}$) - Continuous ($T_C = 100^\circ\text{C}$)	577	W
		288	
T_J	Operating Temperature Range	-55 to +175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	

Thermal Characteristics

Symbol	Parameter	Value			Units
		Min	Typ	Max	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	0.26	-	$^\circ\text{C/W}$

Electrical Characteristics

Static Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 100\mu A$	1200	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 1200V, V_{GS} = 0V$	-	1	100	μA
		$V_{DS} = 1200V, V_{GS} = 0V, T_J = 175^\circ\text{C}$	-	10	100	
$I_{GSS}(+)$	Gate-Source Leakage Current	$V_{GS} = 22V, V_{DS} = 0V$	-	-	± 100	nA
$I_{GSS}(-)$		$V_{GS} = -10V, V_{DS} = 0V$	-	-		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 15mA$	2.0	3.2	5.0	V
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS} = 18V, I_D = 40A$	-	26	45	m Ω
R_G	Gate Resistance	$f = 1\text{ MHz}, V_{AC} = 25mV$	-	1.72	-	Ω

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
C_{iss}	Input Capacitance	$V_{DS} = 800V, V_{GS} = 0V, f = 1MHz, V_{AC} = 25mV$	-	3505	-	pF
C_{oss}	Output Capacitance		-	232	-	
C_{rss}	Reverse Transfer Capacitance		-	39	-	

Switching Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 800V, V_{GS} = -3 / 18V, I_D = 30A, L = 100\mu H, R_G = 4.7\Omega$	-	23.13	-	ns
t_r	Turn-On Rise Time		-	38.25	-	
$t_{d(off)}$	Turn-Off Delay Time		-	59.94	-	
t_f	Turn-Off Fall Time		-	24.3	-	μJ
E_{on}	Turn-On Switching loss		-	681.03	-	
E_{off}	Turn-Off Switching loss	-	248.22	-	nC	
Q_g	Total Gate Charge	-	243	-		
Q_{gs}	Gate-Source Charge	$V_{DS} = 800V, I_D = 30A, V_{GS} = -3 / 18V$	-	37		-
Q_{gd}	Gate-Drain Charge	-	-	113	-	

Body Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I_{SD}	Maximum Continuous Diode Forward Current	$V_{GS} = -3V, T_J = 25^\circ\text{C}$	-	-	76	A
V_{SD}	Diode Forward Voltage	$V_{GS} = -3V, I_S = 30A$	-	5	-	V
T_{rr}	Reverse Recovery Time	$V_R = 800V, V_{GS} = -3V, I_S = 30A, di/dt = 1,000A/ns$	-	32	-	ns
Q_{rr}	Reverse Recovery Charge		-	344	-	nC
I_{rr}	Reverse Recovery Current		-	18	-	A

Typical Characteristics

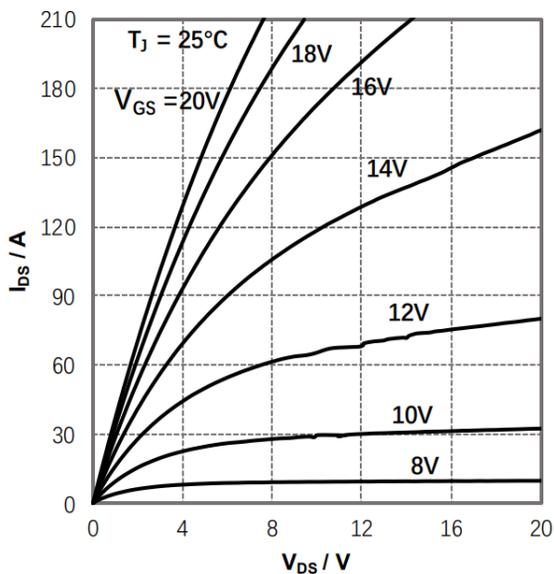


Figure 1. Output Characteristics at $T_J=25^\circ\text{C}$

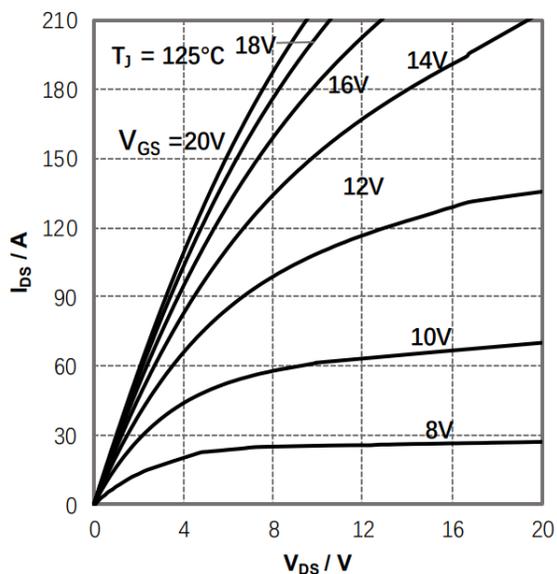


Figure 2. Output Characteristics at $T_J=125^\circ\text{C}$

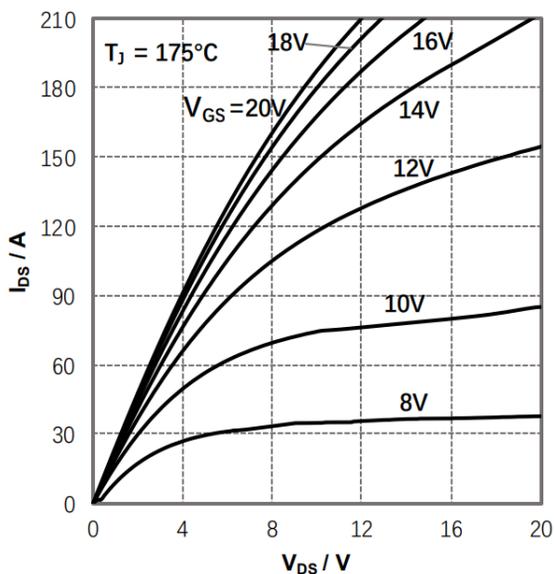


Figure 3. Output Characteristics at $T_J=175^\circ\text{C}$

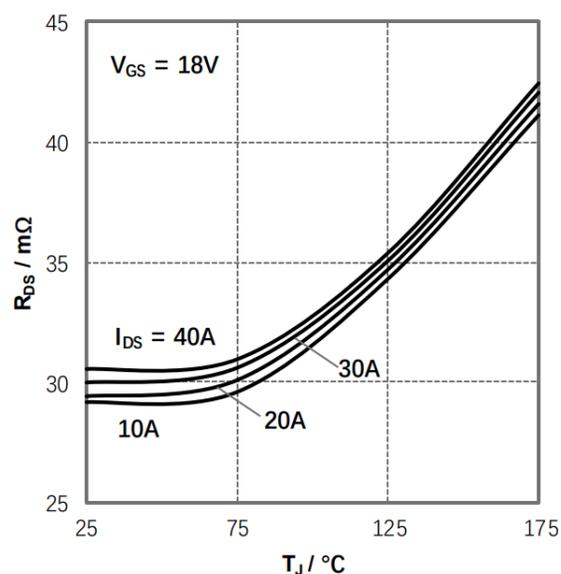


Figure 4. On-resistance vs. Temperature at various Drain Current

Typical Characteristics

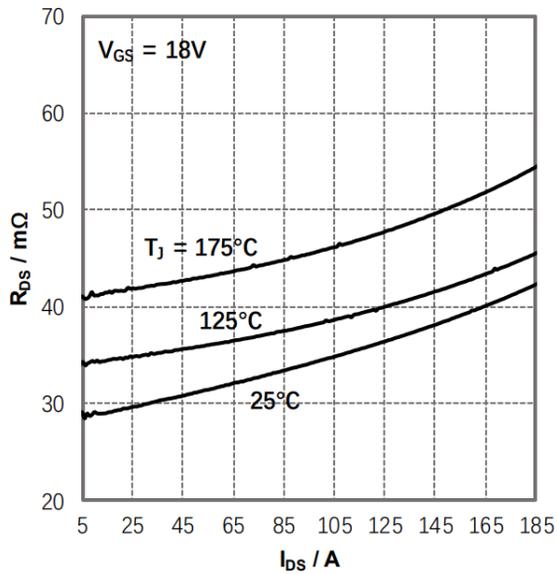


Figure 5. On-Resistance vs. Drain Current at Various Temperature

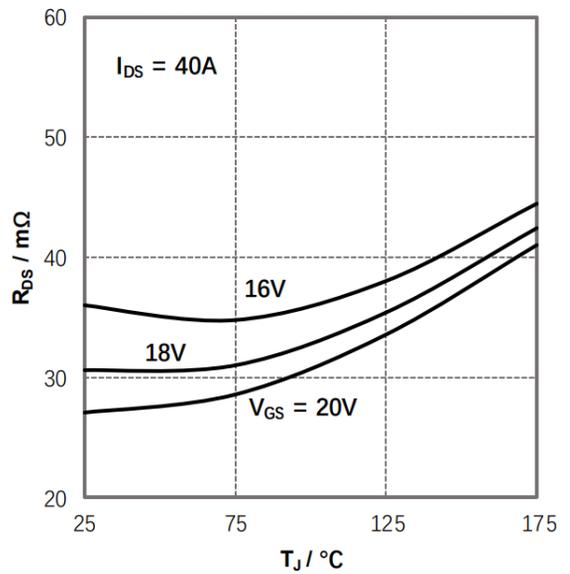


Figure 6. On-Resistance vs. Temperature at Various Gate Voltages

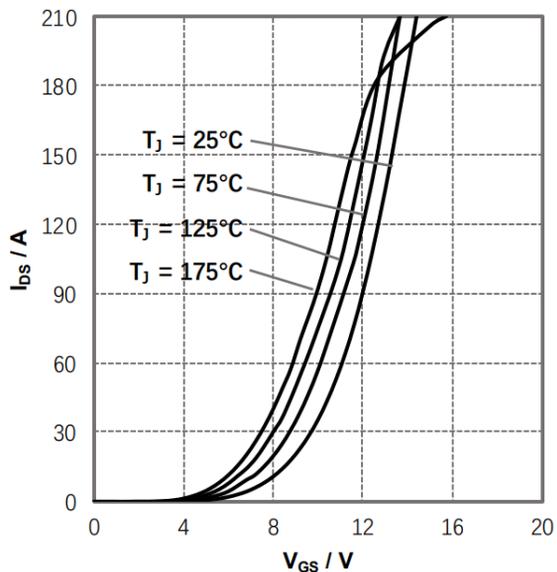


Figure 7. Transfer Characteristics

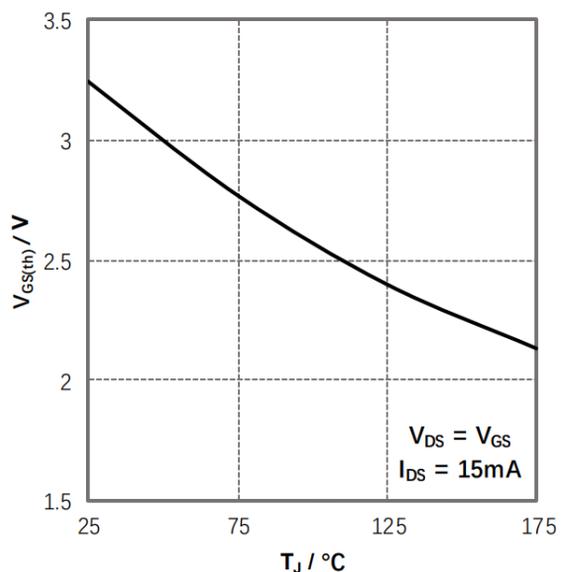


Figure 8. Threshold Voltage vs. Temperature

Typical Characteristics

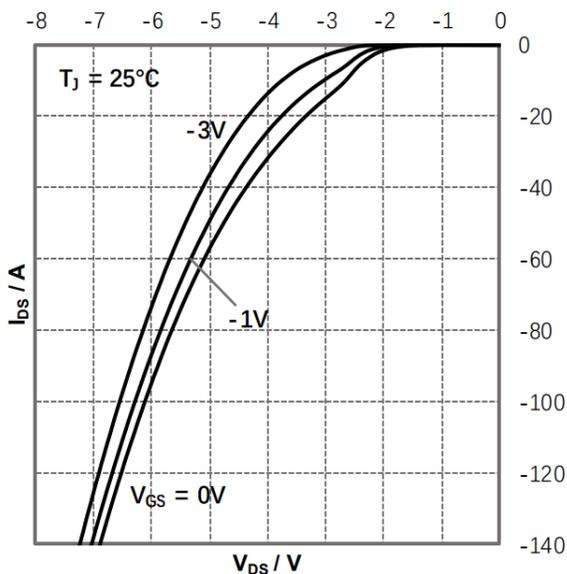


Figure 9. Body Diode Characteristics at $T_J=25^\circ\text{C}$

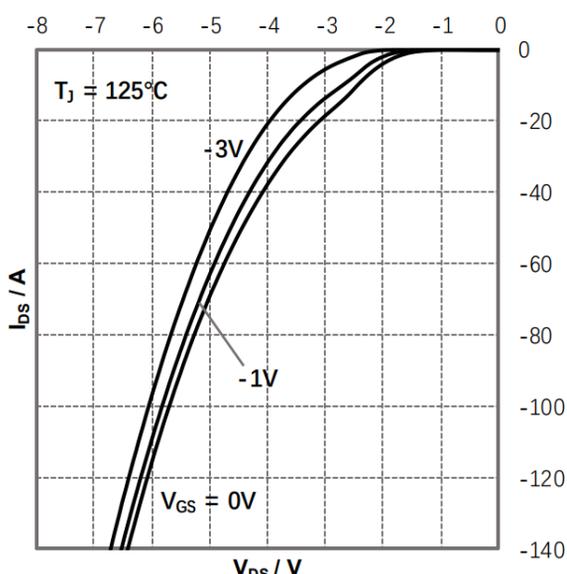


Figure 10. Body Diode Characteristics at $T_J=125^\circ\text{C}$

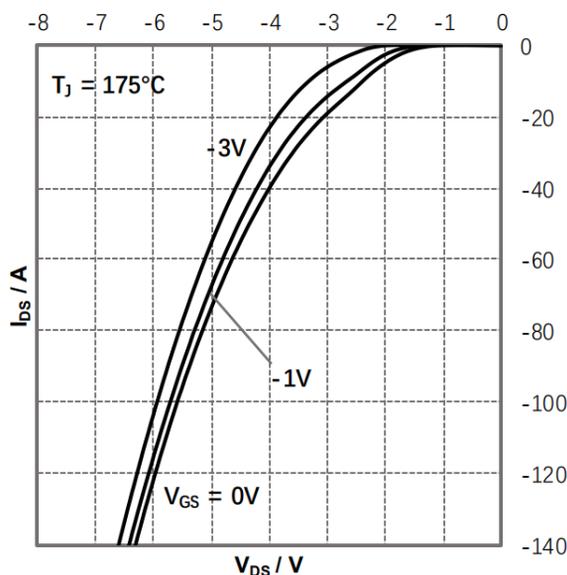


Figure 11. Body Diode Characteristics at $T_J=175^\circ\text{C}$

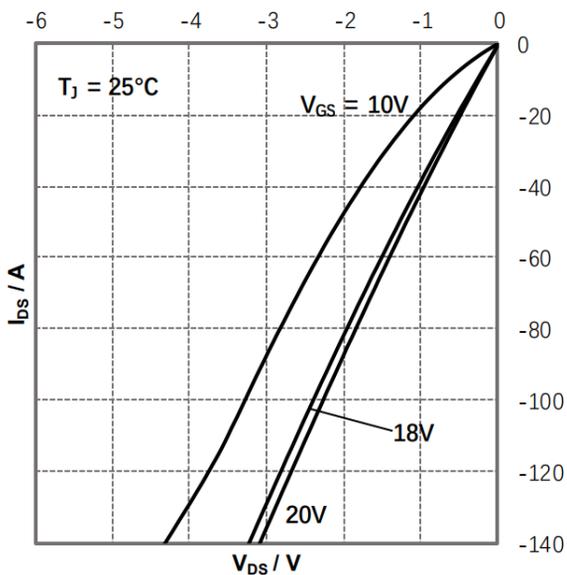


Figure 12. Third-quadrant Conduction Characteristics at $T_J=25^\circ\text{C}$

Typical Characteristics

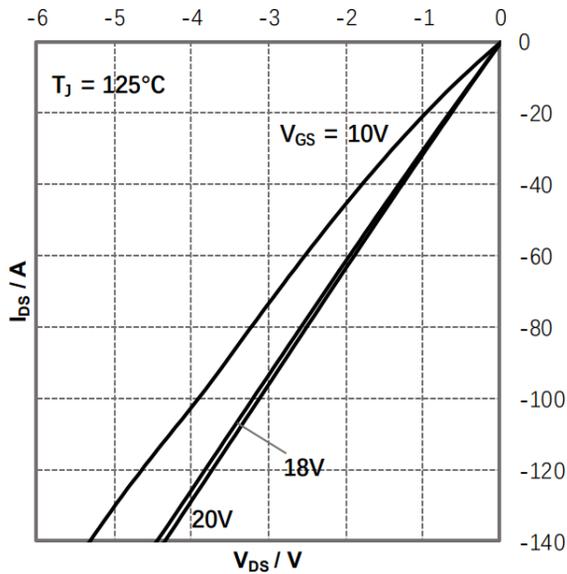


Figure 13. Third-quadrant Conduction Characteristics at $T_J=125^\circ\text{C}$

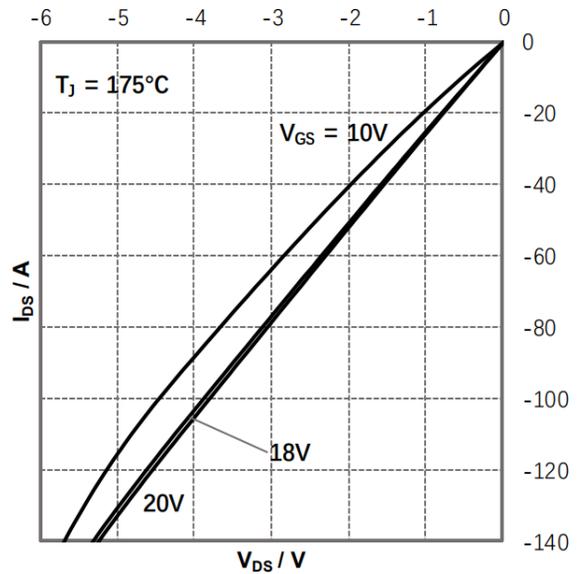


Figure 14. Third-quadrant Conduction Characteristics at $T_J=175^\circ\text{C}$

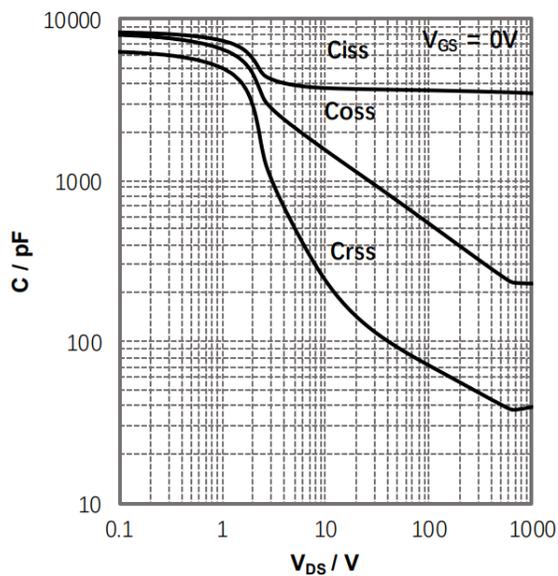


Figure 15. Junction Capacitance vs. Drain to Source Voltage

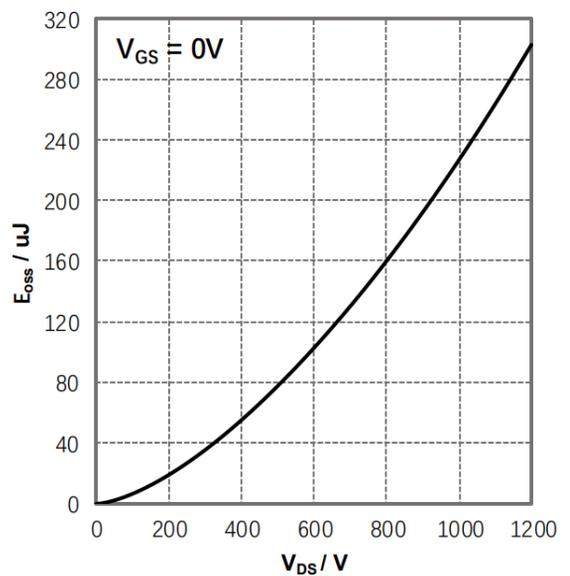


Figure 16. Output Capacitor Energy Storage

Typical Characteristics

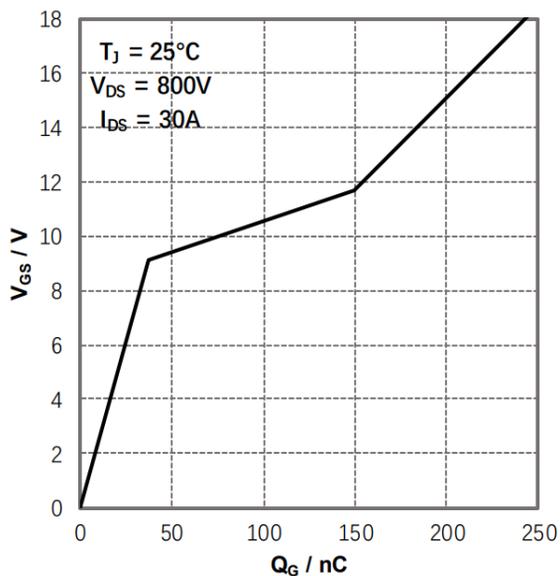


Figure 17. Gate Charge Characteristics

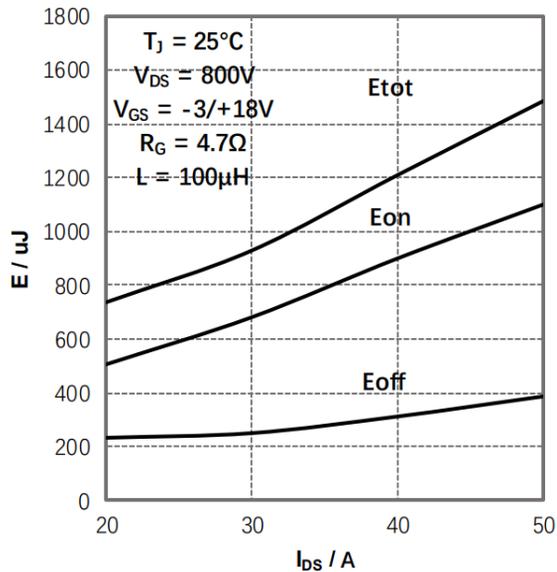


Figure 18. Switching Energy vs. Drain Current

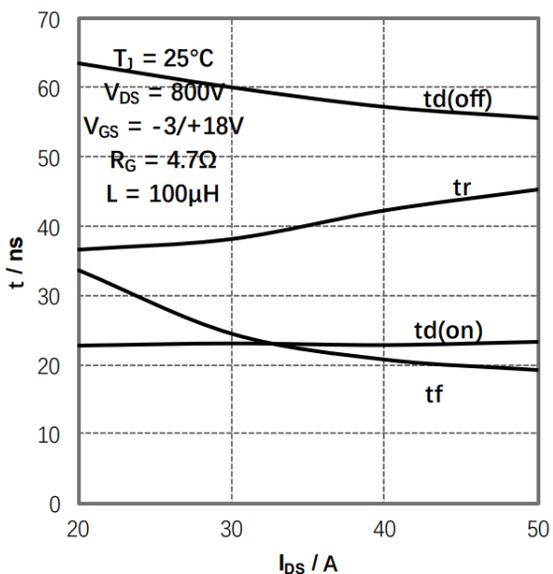


Figure 19. Switching Times vs. Drain Current

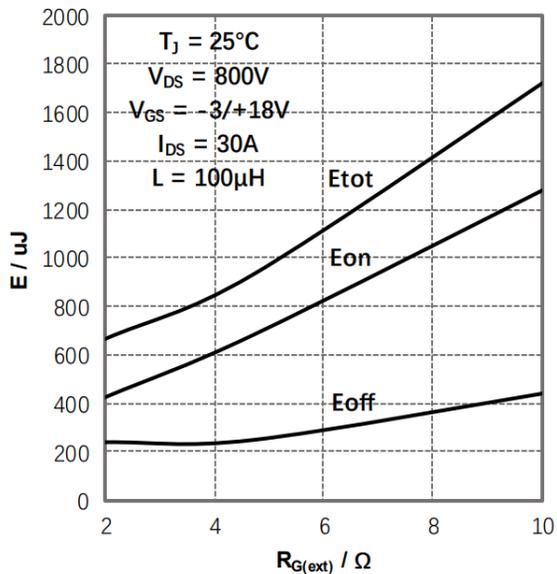


Figure 20. Switching Energy vs. Gate Resistance

Typical Characteristics

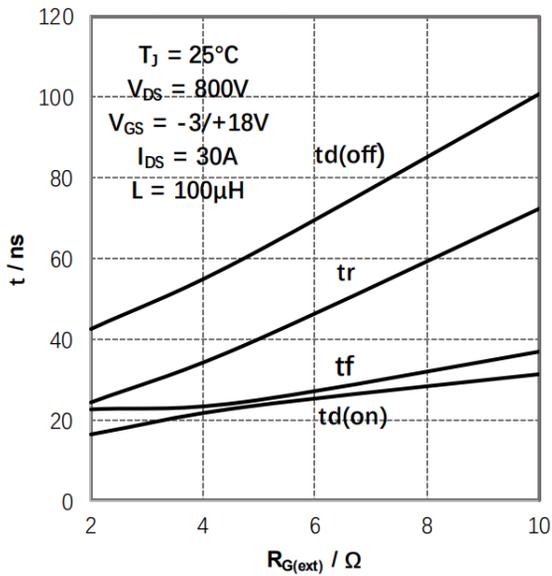


Figure 21. Switching Times vs. Gate Resistance

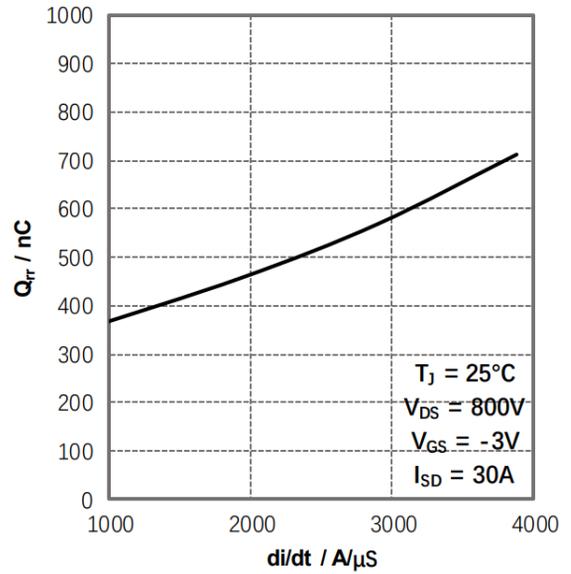


Figure 22. Reverse Recovery Charge vs. di/dt

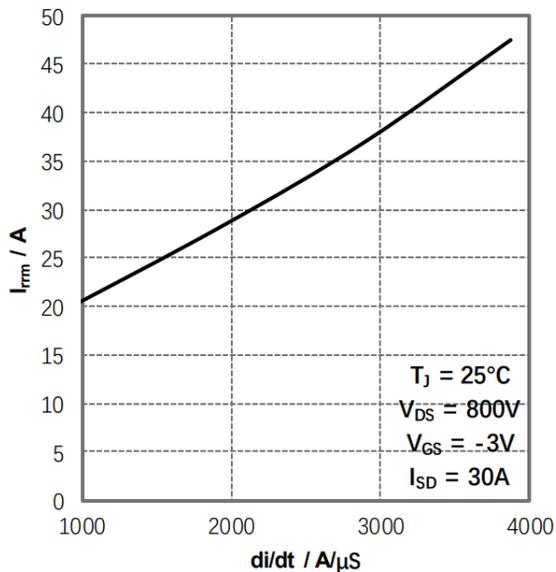


Figure 23. Reverse Recovery Current vs. di/dt

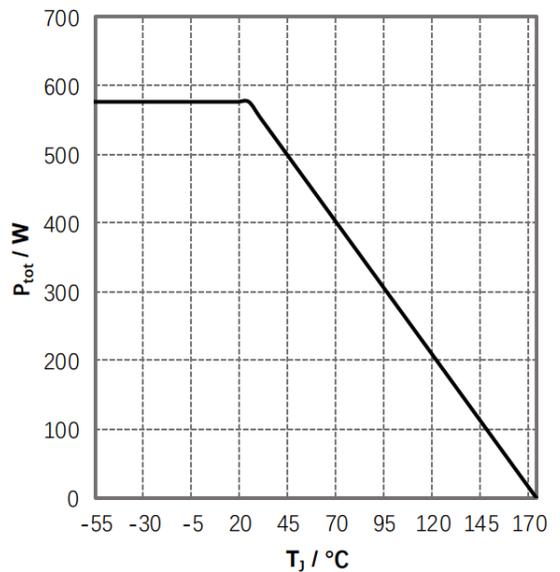


Figure 24. Power Dissipation Derating

Typical Characteristics

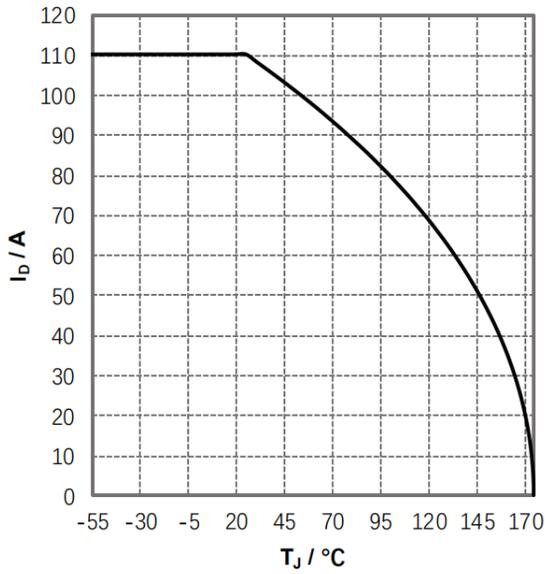


Figure 25. Continuous Drain Current Derating

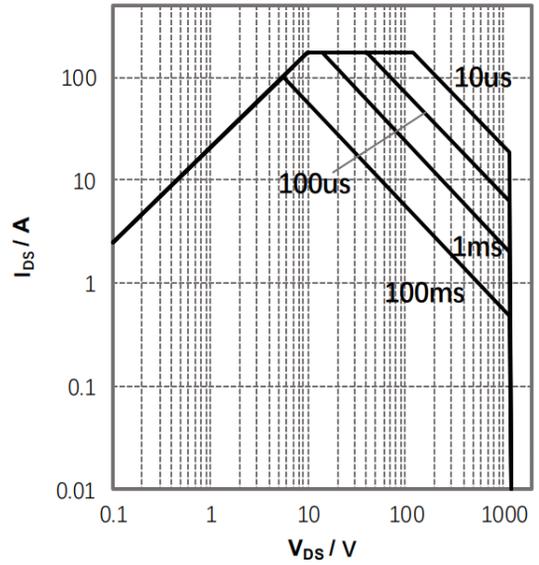


Figure 26. Safe Operation Area

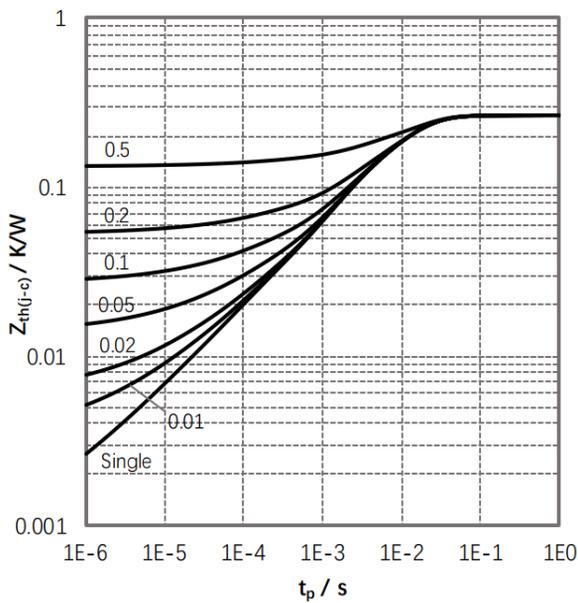
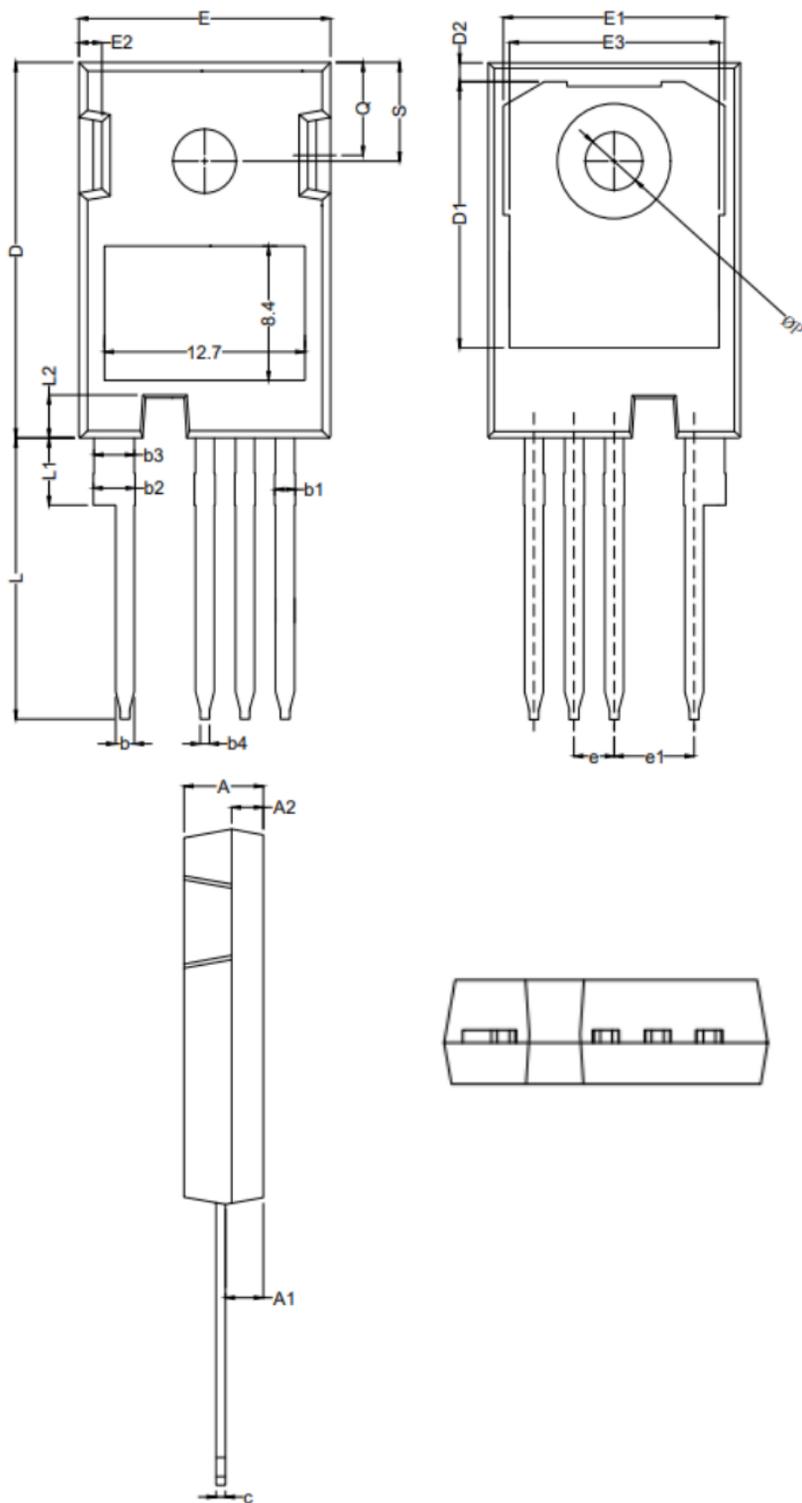


Figure 27. Transient Thermal Impedance

Package Information

Package Outline

Unit : mm



SYMBOL	DIMENSIONS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b	1.07	1.33
b1	1.07	1.60
b2	2.39	2.94
b3	2.39	2.69
b4	0.45	0.75
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	1.00	1.90
E3	12.38	13.45
e	2.54 BSC	
e1	5.08 BSC	
L	17.27	17.82
L1	-	4.37
L2	2.35	2.65
ØP	3.51	3.71
Q	5.49	6.00
S	6.04	6.30